SONY

ICX252AQF

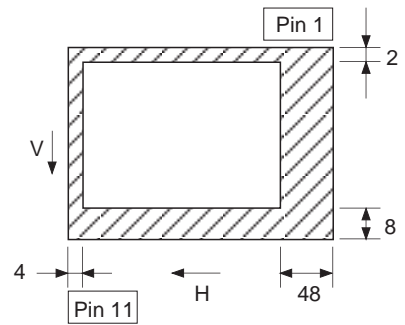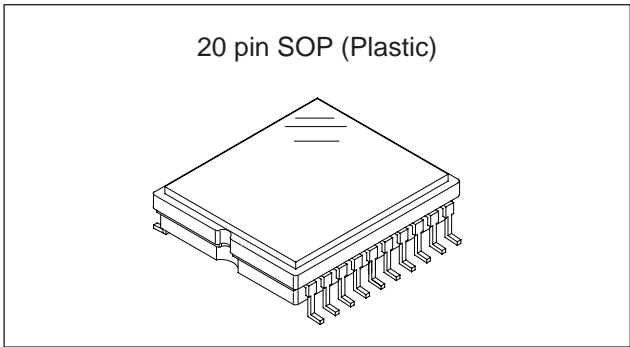## Diagonal 8.933mm (Type 1/1.8) Frame Readout CCD Image Sensor with Square Pixel for Color Cameras

Description

The ICX252AQF is a diagonal 8.933mm (Type 1/1.8) interline CCD solid-state image sensor with a square pixel array and 3.24M effective pixels. Frame readout allows all pixels' signals to be output independently within approximately 1/4.28 second.

Also, number of vertical pixels decimation allows output of 30 frames per second in high frame rate readout mode.

R, G, B primary color mosaic filters are used as the color filters, and at the same time high sensitivity and low dark current are achieved through the adoption of Super HAD CCD technology.

This chip is suitable for applications such as electronic still cameras, etc.

20 pin SOP (Plastic)

Features
• Supports frame readout
• High horizontal and vertical resolution
• Supports high frame rate readout mode: 30 frames/s,
  AF1 mode: 60 frames/s, 50 frames/s,
  AF2 mode: 120 frames/s, 100 frames/s
• Square pixel
• Horizontal drive frequency: 18MHz
• No voltage adjustments (reset gate and substrate bias are not adjusted.)
• R, G, B primary color mosaic filters on chip
• High sensitivity, low dark current
• Continuous variable-speed shutter
• Excellent anti-blooming characteristics
• Exit pupil distance recommended range   −20 to −100mm
• 20-pin high-precision plastic package

Optical black position
(Top View)

Device Structure
• Interline CCD image sensor
• Total number of pixels: 2140 (H) × 1560 (V) approx. 3.34M pixels
• Number of effective pixels: 2088 (H) × 1550 (V) approx. 3.24M pixels
• Number of active pixels: 2080 (H) × 1542 (V) approx. 3.21M pixels diagonal 8.933mm
• Number of recommended record pixels: 2048 (H) × 1536 (V) approx. 3.15M pixels diagonal 8.832mm
                                           aspect ratio 4:3
• Chip size: 8.10mm (H) × 6.64mm (V)
• Unit cell size: 3.45μm (H) × 3.45μm (V)
• Optical black: Horizontal (H) direction: Front 4 pixels, rear 48 pixels
                                           Vertical (V) direction: Front 8 pixels, rear 2 pixels
• Number of dummy bits: Horizontal 28
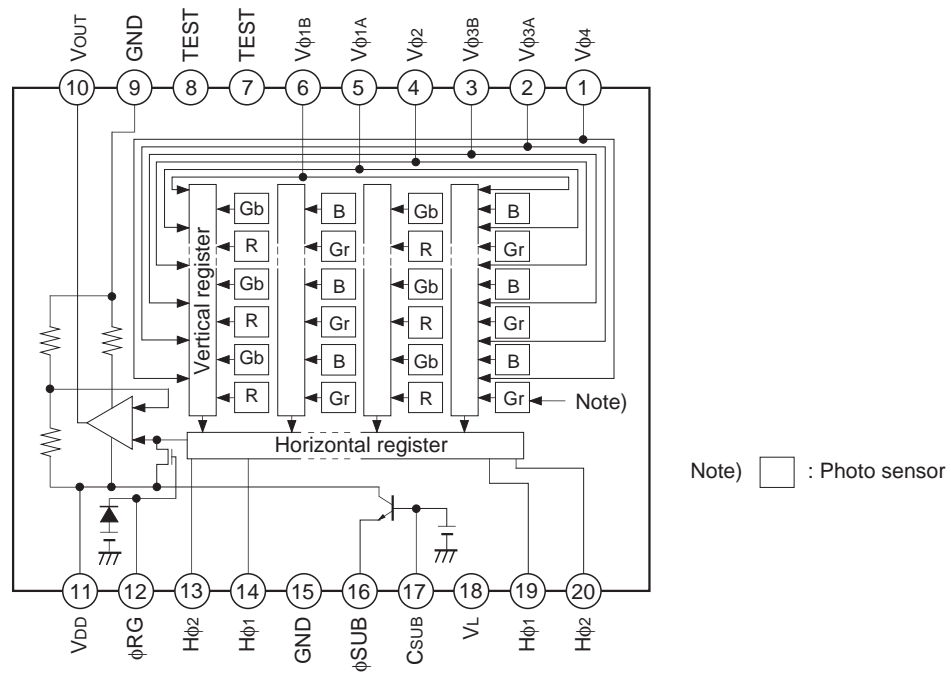   Vertical 1 (even fields only)
• Substrate material: Silicon

Super HAD CCD ™

E00110-PS

Block Diagram and Pin Configuration

(Top View)

Pin labels (top, left to right): 10 V_{OUT}, 9 GND, 8 TEST, 7 TEST, 6 $V\phi_{1B}$, 5 $V\phi_{1A}$, 4 $V\phi_2$, 3 $V\phi_{3B}$, 2 $V\phi_{3A}$, 1 $V\phi_4$

Internal blocks: Vertical register, Gb, R, Gb, B, Gr, Gb, R, Gb, B, Gr, Horizontal register

Pin labels (bottom, left to right): 11 V_{DD}, 12 ϕRG, 13 $H\phi_2$, 14 $H\phi_1$, 15 GND, 16 ϕSUB, 17 C_{SUB}, 18 V_L, 19 $H\phi_1$, 20 $H\phi_2$

Note) □ : Photo sensor

Pin Description

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	$V\phi_4$	Vertical register transfer clock	11	V_{DD}	Supply voltage
2	$V\phi_{3A}$	Vertical register transfer clock	12	ϕRG	Reset gate clock
3	$V\phi_{3B}$	Vertical register transfer clock	13	$H\phi_2$	Horizontal register transfer clock
4	$V\phi_2$	Vertical register transfer clock	14	$H\phi_1$	Horizontal register transfer clock
5	$V\phi_{1A}$	Vertical register transfer clock	15	GND	GND
6	$V\phi_{1B}$	Vertical register transfer clock	16	ϕSUB	Substrate clock
7	TEST	Test pin[1]	17	C_{SUB}	Substrate bias[2]
8	TEST	Test pin[1]	18	V_L	Protective transistor bias
9	GND	GND	19	$H\phi_1$	Horizontal register transfer clock
10	V_{OUT}	Signal output	20	$H\phi_2$	Horizontal register transfer clock

[1] Leave this pin open.

[2] DC bias is generated within the CCD, so that this pin should be grounded externally through a capacitance of 0.1µF.

Absolute Maximum Ratings

Item		Ratings	Unit	Remarks
Against ϕSUB	V_{DD}, V_{OUT}, ϕRG – ϕSUB	–40 to +12	V	
	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_{3A}$, $V\phi_{3B}$ – ϕSUB	–50 to +15	V	
	$V\phi_2$, $V\phi_4$, V_L – ϕSUB	–50 to +0.3	V	
	$H\phi_1$, $H\phi_2$, GND – ϕSUB	–40 to +0.3	V	
	C_{SUB} – ϕSUB	–25 to	V	
Against ϕSUB	V_{DD}, V_{OUT}, ϕRG, C_{SUB} – GND	–0.3 to +22	V	
	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_2$, $V\phi_{3A}$, $V\phi_{3B}$, $V\phi_4$ – GND	–10 to +18	V	
	$H\phi_1$, $H\phi_2$ – GND	–10 to +6.5	V	
Against V_L	$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_{3A}$, $V\phi_{3B}$ – V_L	–0.3 to +28	V	
	$V\phi_2$, $V\phi_4$, $H\phi_1$, $H\phi_2$, GND – V_L	–0.3 to +15	V	
Between input clock pins	Voltage difference between vertical clock input pins	to +15	V	*1
	$H\phi_1$ – $H\phi_2$	–6.5 to +6.5	V	
	$H\phi_1$, $H\phi_2$ – $V\phi_4$	–10 to +16	V	
Storage temperature		–30 to +80	°C	
Guaranteed temperature of performance		–10 to +60	°C	
Operating temperature		–10 to +75	°C	

*1 +24V (Max.) when clock width < 10μs, clock duty factor < 0.1%.
  +16V (Max.) is guaranteed for turning on or off power supply.

Bias Conditions

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply voltage	V_{DD}	14.55	15.0	15.45	V	
Protective transistor bias	V_L		*1			
Substrate clock	ϕSUB		*2			
Reset gate clock	ϕRG		*2			

*1 V_L setting is the V_{VL} voltage of the vertical transfer clock waveform, or the same voltage as the V_L power supply for the V driver should be used.

*2 Do not apply a DC bias to the substrate clock and reset gate clock pins, because a DC bias is generated within the CCD.

DC Characteristics

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply current	I_{DD}	2.0	4.5	7.0	mA	

Clock Voltage Conditions

Item	Symbol	Min.	Typ.	Max.	Unit	Waveform diagram	Remarks
Readout clock voltage	V_{VT}	14.55	15.0	15.45	V	1	
Vertical transfer clock voltage	V_{VH1}, V_{VH2}	−0.05	0	0.05	V	2	$V_{VH} = (V_{VH1} + V_{VH2})/2$
	V_{VH3}, V_{VH4}	−0.2	0	0.05	V	2	
	$V_{VL1}, V_{VL2}, V_{VL3}, V_{VL4}$	−8.0	−7.5	−7.0	V	2	$V_{VL} = (V_{VL3} + V_{VL4})/2$
	$V\phi V$	6.8	7.5	8.05	V	2	$V\phi V = V_{VHn} − V_{VLn}$ (n = 1 to 4)
	$V_{VH3} − V_{VH}$	−0.25		0.1	V	2	
	$V_{VH4} − V_{VH}$	−0.25		0.1	V	2	
	V_{VHH}			0.6	V	2	High-level coupling
	V_{VHL}			0.9	V	2	High-level coupling
	V_{VLH}			0.9	V	2	Low-level coupling
	V_{VLL}			0.5	V	2	Low-level coupling
Horizontal transfer clock voltage	$V\phi H$	4.75	5.0	5.25	V	3	
	V_{HL}	−0.05	0	0.05	V	3	
	V_{CR}	0.8	2.5		V	3	Cross-point voltage
Reset gate clock voltage	$V\phi RG$	3.0	3.3	5.25	V	4	
	$V_{RGLH} − V_{RGLL}$			0.4	V	4	Low-level coupling
	$V_{RGL} − V_{RGLm}$			0.5	V	4	Low-level coupling
Substrate clock voltage	$V\phi SUB$	21.5	22.5	23.5	V	5	

Clock Equivalent Circuit Constant

| Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Capacitance between vertical transfer clock and GND	$C_{\phi V1A}$, $C_{\phi V3A}$		1500		pF	
	$C_{\phi V1B}$, $C_{\phi V3B}$		5600		pF	
	$C_{\phi V2}$, $C_{\phi V4}$		2700		pF	
Capacitance between vertical transfer clocks	$C_{\phi V1A2}$, $C_{\phi V3A4}$		390		pF	
	$C_{\phi V1B2}$, $C_{\phi V3B4}$		470		pF	
	$C_{\phi V23A}$, $C_{\phi V41A}$		120		pF	
	$C_{\phi V23B}$, $C_{\phi V41B}$		180		pF	
	$C_{\phi V1A3A}$		39		pF	
	$C_{\phi V1B3B}$		220		pF	
	$C_{\phi V1A3B}$, $C_{\phi V1B3A}$		62		pF	
	$C_{\phi V24}$		75		pF	
	$C_{\phi V1A1B}$, $C_{\phi V3A3B}$		68		pF	
Capacitance between horizontal transfer clock and GND	$C_{\phi H1}$, $C_{\phi H2}$		36.5		pF	
Capacitance between horizontal transfer clocks	$C_{\phi HH}$		88.5		pF	
Capacitance between reset gate clock and GND	$C_{\phi RG}$		8		pF	
Capacitance between substrate clock and GND	$C_{\phi SUB}$		1000		pF	
Vertical transfer clock series resistor	R_{1A}, R_{1B}, R_2, R_{3A}, R_{3B}, R_4		62		Ω	
Vertical transfer clock ground resistor	R_{GND}		18		Ω	
Horizontal transfer clock series resistor	$R_{\phi H}$		15		Ω	
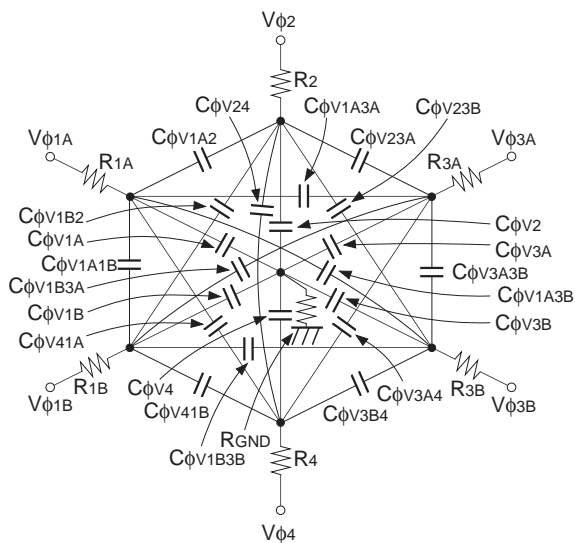
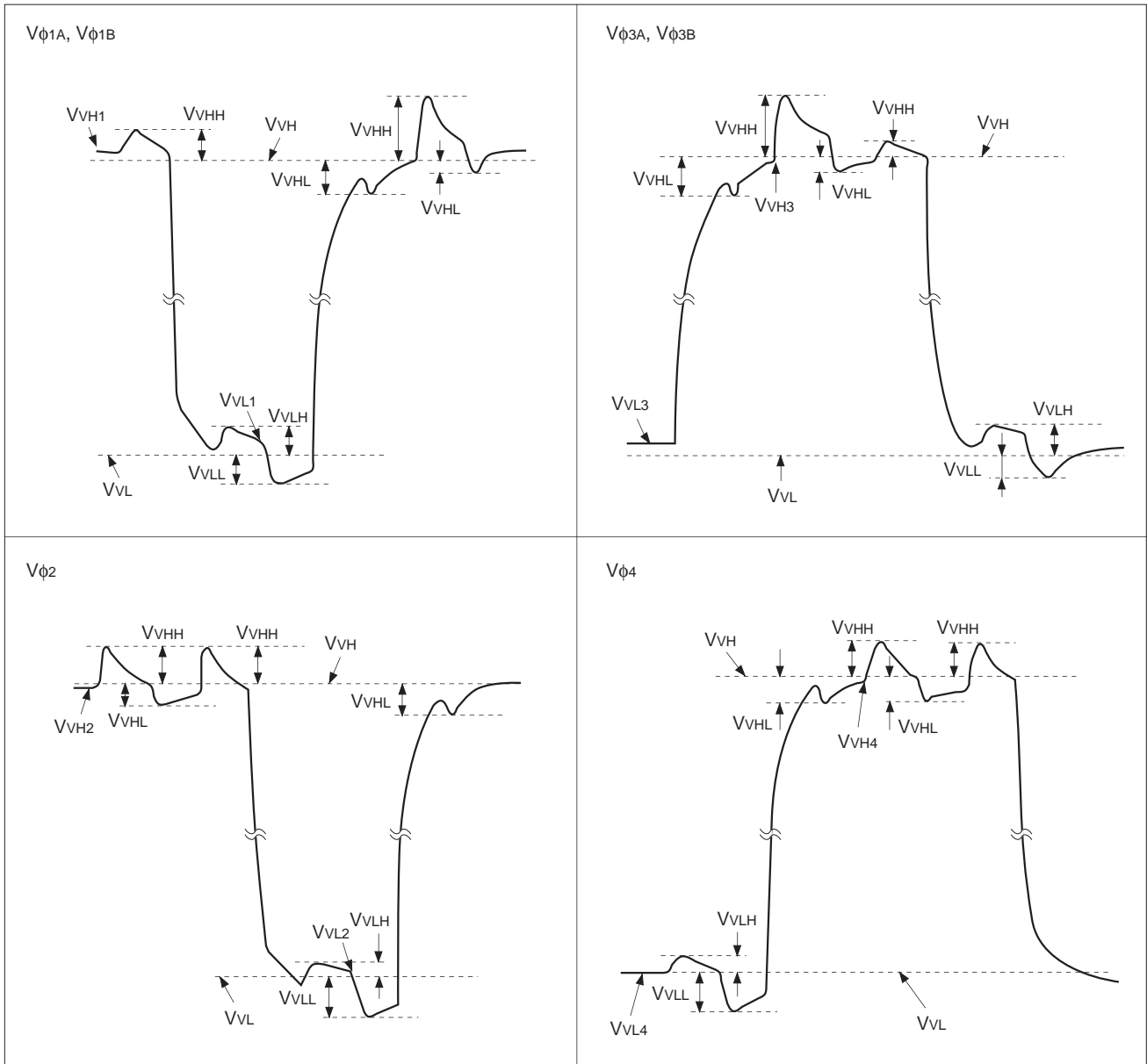**Vertical transfer clock equivalent circuit**
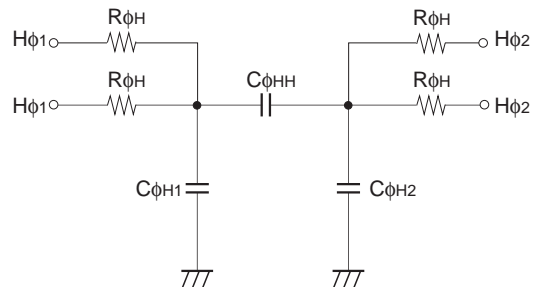
Horizontal transfer clock equivalent circuit

Drive Clock Waveform Conditions

(1) Readout clock waveform
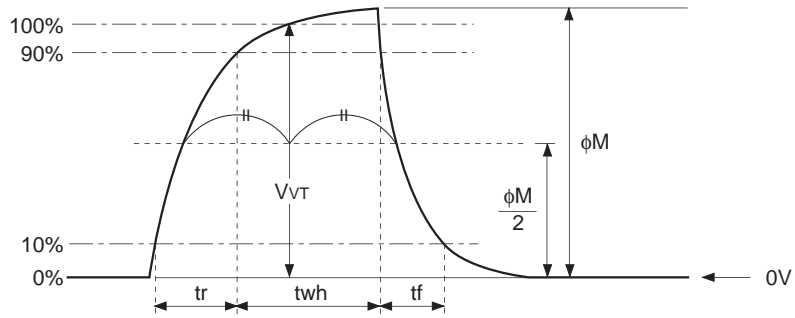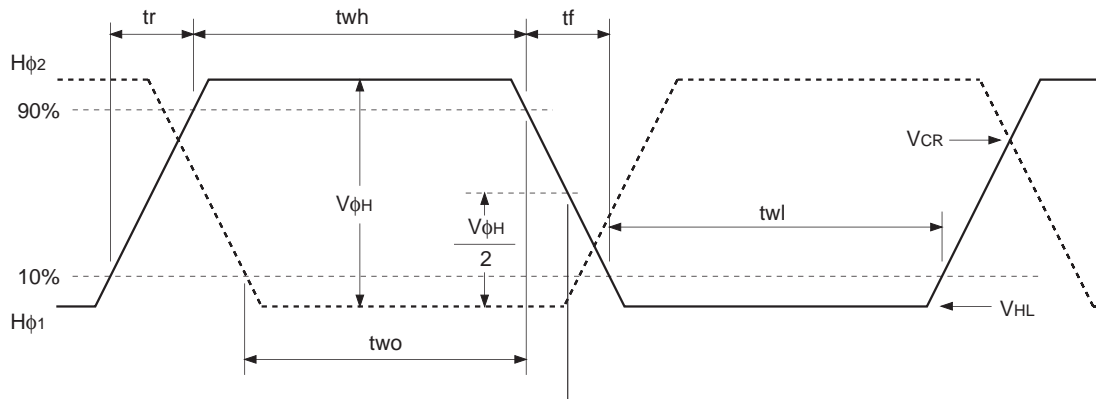

(2) Vertical transfer clock waveform

$V_{VH} = (V_{VH1} + V_{VH2})/2$
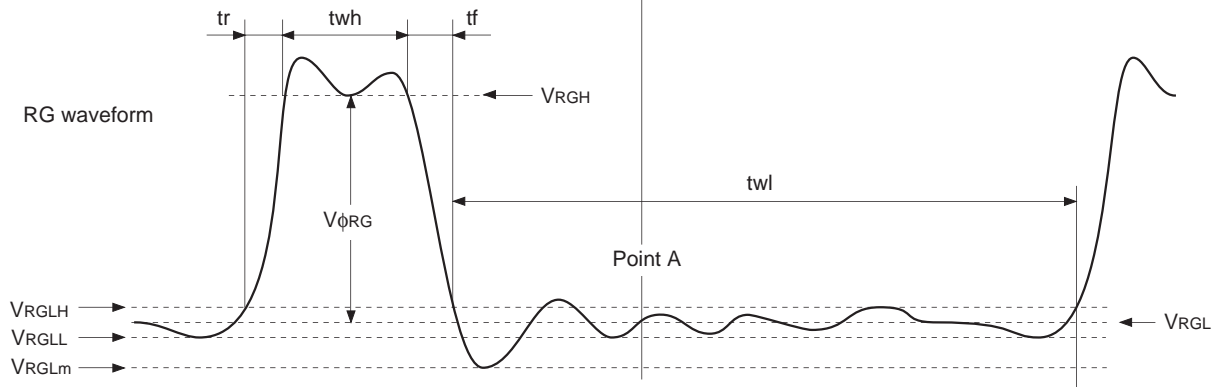
$V_{VL} = (V_{VL3} + V_{VL4})/2$

$V_{\phi V} = V_{VH}n - V_{VL}n$ (n = 1 to 4)

– 6 –

(3) Horizontal transfer clock waveform

Cross-point voltage for the Hϕ1 rising side of the horizontal transfer clocks Hϕ1 and Hϕ2 waveforms is V$_{CR}$.
The overlap period for twh and twl of horizontal transfer clocks Hϕ1 and Hϕ2 is two.

(4) Reset gate clock waveform

V$_{RGLH}$ is the maximum value and V$_{RGLL}$ is the minimum value of the coupling waveform during the period from
Point A in the above diagram until the rising edge of RG.
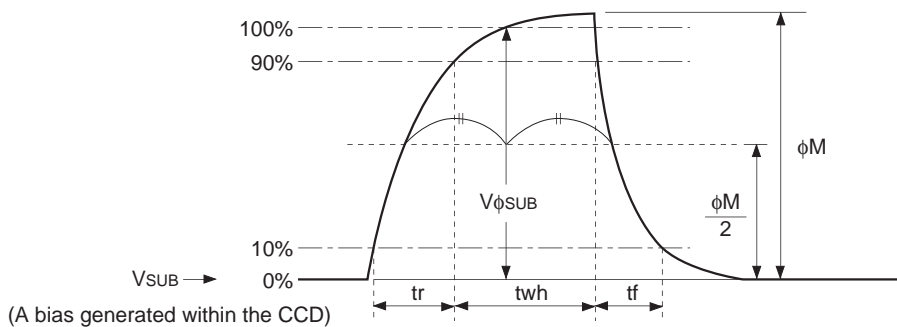In addition, V$_{RGL}$ is the average value of V$_{RGLH}$ and V$_{RGLL}$.

$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2$$

Assuming V$_{RGH}$ is the minimum value during the interval twh, then:

$$V\phi_{RG} = V_{RGH} - V_{RGL}$$

Negative overshoot level during the falling edge of RG is V$_{RGLm}$.

(5) Substrate clock waveform

(A bias generated within the CCD)

Clock Switching Characteristics (Horizontal drive frequency: 18MHz)

Item		Symbol	twh			twl			tr			tf			Unit	Remarks
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.		
Readout clock		V_T	2.63	2.83						0.5			0.5		µs	During readout
Vertical transfer clock		$V\phi_{1A}$, $V\phi_{1B}$, $V\phi_2$, $V\phi_{3A}$, $V\phi_{3B}$, $V\phi_4$										15		250	ns	When using CXD3400N
Horizontal transfer clock	During imaging	$H\phi_1$	14	19.5		14	19.5			8.5	14		8.5	14	ns	tf ≥ tr – 2ns
		$H\phi_2$	14	19.5		14	19.5			8.5	14		8.5	14		
	During parallel-serial conversion	$H\phi_1$		6.67						0.01			0.01		µs	
		$H\phi_2$					5.56			0.01			0.01			
Reset gate clock		ϕ_{RG}	7	10			37			4			5		ns	
Substrate clock		ϕ_{SUB}	1.7	3.06							0.5			0.5	µs	During drain charge

Item	Symbol	two			Unit	Remarks
		Min.	Typ.	Max.		
Horizontal transfer clock	$H\phi_1$, $H\phi_2$	12	19.5		ns	

Spectral Sensitivity Characteristics (excludes lens characteristics and light source characteristics)
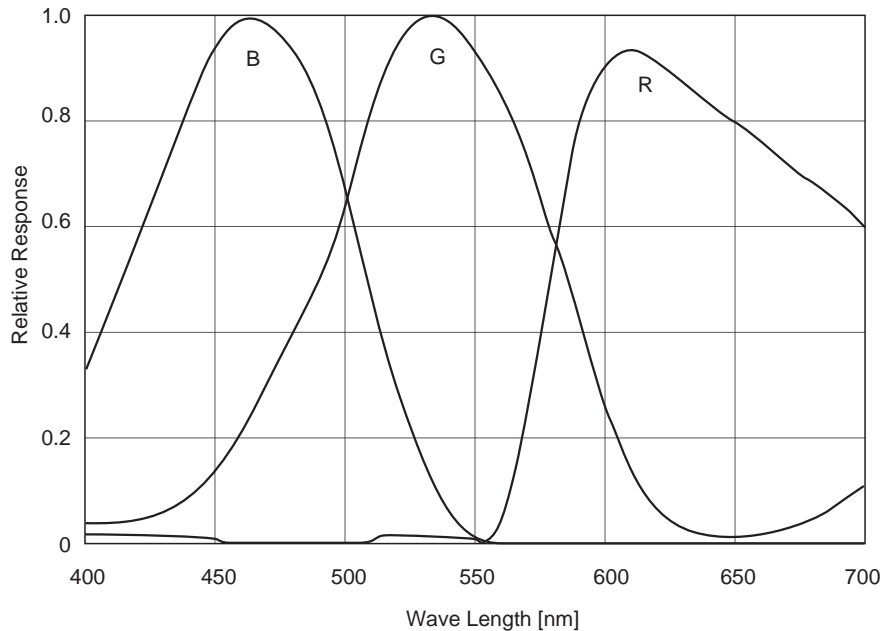
Image Sensor Characteristics (Horizontal drive frequency: 18MHz)   (Ta = 25°C)

Item		Symbol	Min.	Typ.	Max.	Unit	Measurement method	Remarks
G sensitivity		Sg	220	270		mV	1	1/30s accumulation
Sensitivity comparison	R	Rr	0.3	0.45	0.6		1	
	B	Rb	0.35	0.50	0.65		1	
Saturation signal		Vsat	450			mV	2	Ta = 60°C,[*1]
Smear		Sm		−89.1	−81.2	dB	3	Frame readout mode,[*2]
				−79.6	−71.6			High frame rate readout mode
Video signal shading		SHg			20	%	4	Zone 0 and I
					25			Zone 0 to II'
Dark signal		Vdt			12	mV	5	Ta = 60°C, 4.28 frame/s
Dark signal shading		ΔVdt			6	mV	6	Ta = 60°C, 4.28 frame/s,[*3]
Line crawl G		Lcg			3.8	%	7	
Line crawl R		Lcr			3.8	%	7	
Line crawl B		Lcb			3.8	%	7	
Lag		Lag			0.5	%	8	

[*1] The saturation signal level is 450mV or more by performing pull-down C_{SUB} pin at 1.3kΩ resistor.
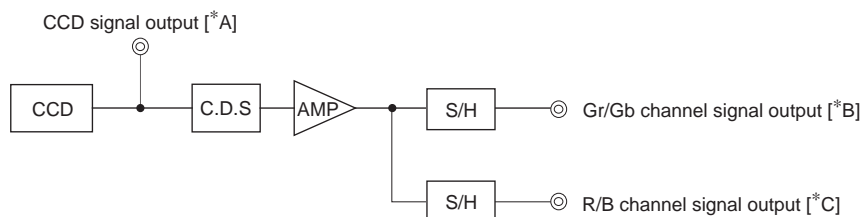For high frame rate readout mode, it is 800mV.

[*2] After closing the mechanical shutter, the smear can be reduced to below the detection limit by performing vertical register sweep operation.

[*3] Excludes vertical dark signal shading caused by vertical register high-speed transfer.

**Zone Definition of Video Signal Shading**
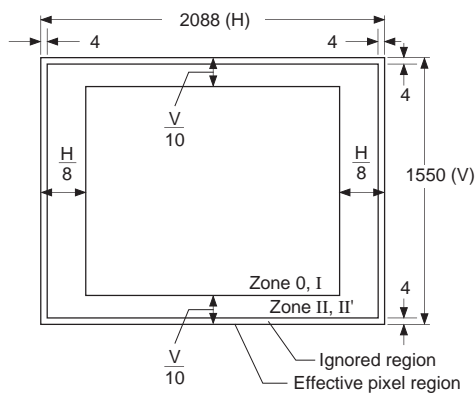
Measurement System

Note) Adjust the amplifier gain so that the gain between [*A] and [*B], and between [*A] and [*C] equals 1.

Image Sensor Characteristics Measurement Method

◎ **Measurement conditions**

1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions, and the frame readout mode is used.

2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value of the Gr/Gb channel signal output or the R/B channel signal output of the measurement system.

◎ **Color coding of this image sensor & Readout**

B2 —	Gb	B	Gb	B	
	R	Gr	R	Gr	— A2
B1 —	Gb	B	Gb	B	
	R	Gr	R	Gr	— A1
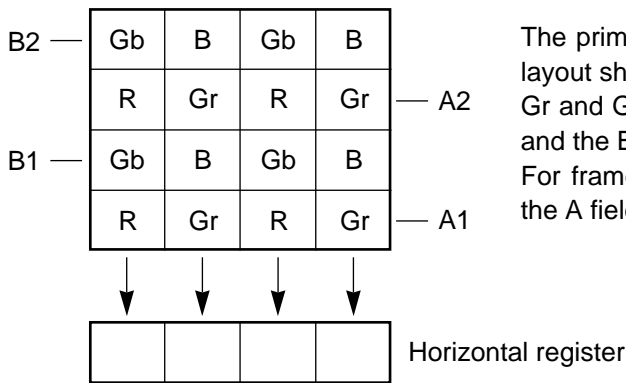
The primary color filters of this image sensor are arranged in the layout shown in the figure on the left (Bayer arrangement).
Gr and Gb denote the G signals on the same line as the R signal and the B signal, respectively.
For frame readout, the A1 and A2 lines are output as signals in the A field, and the B1 and B2 lines in the B field.

Horizontal register

Color Coding Diagram

◎ **Readout modes**

1. Readout modes list

The following readout modes are possible by driving the image sensor at the timing specifications noted in this Data Sheet.

Mode name		Frame rate	Number of output effective lines
Frame readout mode	NTSC mode	4.28 frame/s	1550 (Odd 775, Even 775)
	PAL mode	4.16 frame/s	1550 (Odd 775, Even 775)
High frame rate readout mode	NTSC mode	30 frame/s	258
	PAL mode	25 frame/s	258
AF1 mode	NTSC mode	60 frame/s	See Page.12
	PAL mode	50 frame/s	See Page.12
AF2 mode	NTSC mode	120 frame/s	See Page.12
	PAL mode	100 frame/s	See Page.12

2. Frame readout mode, high frame rate readout mode
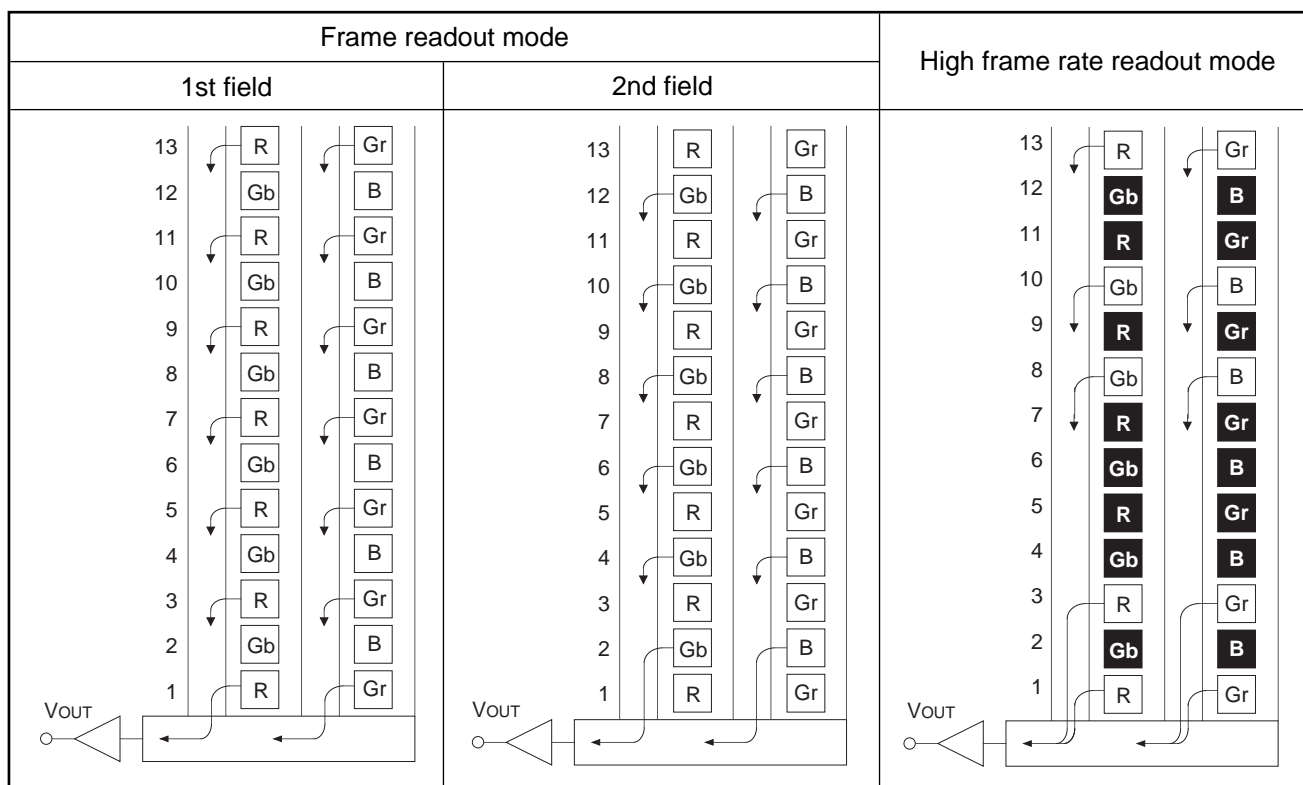
Note) Blacked out portions in the diagram indicate pixels which are not read out.

1. Frame readout mode
   In this mode, all pixel signals are divided into two fields and output.
   All pixel signals are read out independently, making this mode suitable for high resolution image capturing.

2. High frame rate readout mode
   Output is performed at 30 frames per second by reading out 4 pixels for every 12 vertical pixels and adding 2 pixels in the horizontal CCD.
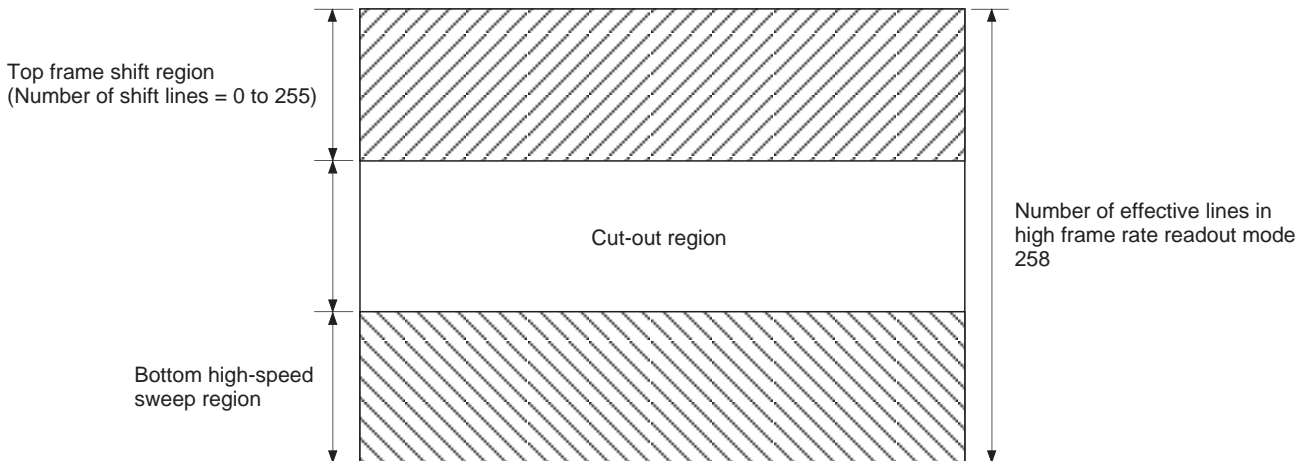   The number of output lines is 258 lines.
   This readout mode emphasizes processing speed over vertical resolution.

3. AF1 mode, AF2 mode

The AF modes increase the frame rate by cutting out a portion of the picture through high-speed elimination of the top and bottom of the picture in high frame rate readout mode. AF1 allows 1/60s and 1/50s output, and AF2 allows 1/120s and 1/100s output, so these modes are effective for raising the auto focus (AF) speed.
In addition, the cut-out can begin from an optional line by controlling the number of frame shift lines that sweep the top of the picture. The relation between the number of frame shift lines, the output start position and number of output lines is shown in the table below.

Top frame shift region
(Number of shift lines = 0 to 255)

Cut-out region

Number of effective lines in
high frame rate readout mode
258

Bottom high-speed
sweep region

	AF1 mode		AF2 mode	
	NTSC	PAL	NTSC	PAL
Frame rate	1/60s	1/50s	1/120s	1/100s
Output start position on timing chart	26H	26H	30H	30H
Number of frame shift lines	$i = 0$ to 255			
Output lines[1]	$i + 3$ to $i + 108$	$i + 3$ to $i + 134$	$i + 3$ to $i + 38$	$i + 3$ to $i + 47$

[1] Output line is Up to 258 lines.
The $i + 1$ and $i + 2$ line signals may be disrupted by elimination of the picture top, so these lines should not be used.

For example, if the picture top is eliminated with $i = 100$ in AF1 mode (NTSC), lines 103 to 208 in high frame rate readout mode are output from 26H of the timing chart.
If the picture top is eliminated with $i = 160$ in AF1 mode (NTSC), lines 163 to 258 in high frame rate readout mode are output from 26H of the timing chart.

◎ **Definition of standard imaging conditions**

1) Standard imaging condition I:
   Use a pattern box (luminance: 706cd/m^2, color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F5.6. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

2) Standard imaging condition II:
   Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

3) Standard imaging condition III:
   Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens (exit pupil distance –33mm) with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. G sensitivity, sensitivity comparison
   Set to standard imaging condition I. After selecting the electronic shutter mode with a shutter speed of 1/100s, measure the signal outputs (V_{Gr}, V_{Gb}, V_R and V_B) at the center of each Gr, Gb, R and B channel screen, and substitute the values into the following formulas.

   $V_G = (V_{Gr} + V_{Gb})/2$
   $Sg = V_G \times 100/30$ [mV]
   $Rr = V_R/V_G$
   $Rb = V_B/V_G$

2. Saturation signal
   Set to standard imaging condition II. After adjusting the luminous intensity to 20 times the intensity with the average value of the Gr signal output, 150mV, measure the minimum values of the Gr, Gb, R and B signal outputs.

3. Smear
   Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, first adjust the average value of the Gr signal output to 150mV. Measure the average values of the Gr signal output, Gb signal output, R signal output and B signal output (Gra, Gba, Ra, Ba), and then adjust the luminous intensity to 500 times the intensity with the average value of the Gr signal output, 150mV. After the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (V_{Sm} [mV]) independent of the Gr, Gb, R and B signal outputs, and substitute the values into the following formula.

   $$Sm = 20 \times \log \left(V_{sm} \div \frac{Gra + Gba + Ra + Ba}{4} \times \frac{1}{500} \times \frac{1}{10} \right) \text{ [dB] (1/10V method conversion value)}$$

4. Video signal shading
   Set to standard imaging condition III. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity so that the average value of the Gr signal output is 150mV. Then measure the maximum (Grmax [mV]) and minimum (Grmin [mV]) values of the Gr signal output and substitute the values into the following formula.

   $SHg = (Grmax - Grmin)/150 \times 100$ [%]

5. Dark signal

   Measure the average value of the signal output (Vdt [mV]) with the device ambient temperature 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

6. Dark signal shading

   After measuring 5, measure the maximum (Vdmax [mV]) and minimum (Vdmin [mV]) values of the dark signal output and substitute the values into the following formula.

   $$\Delta Vdt = Vdmax - Vdmin \text{ [mV]}$$
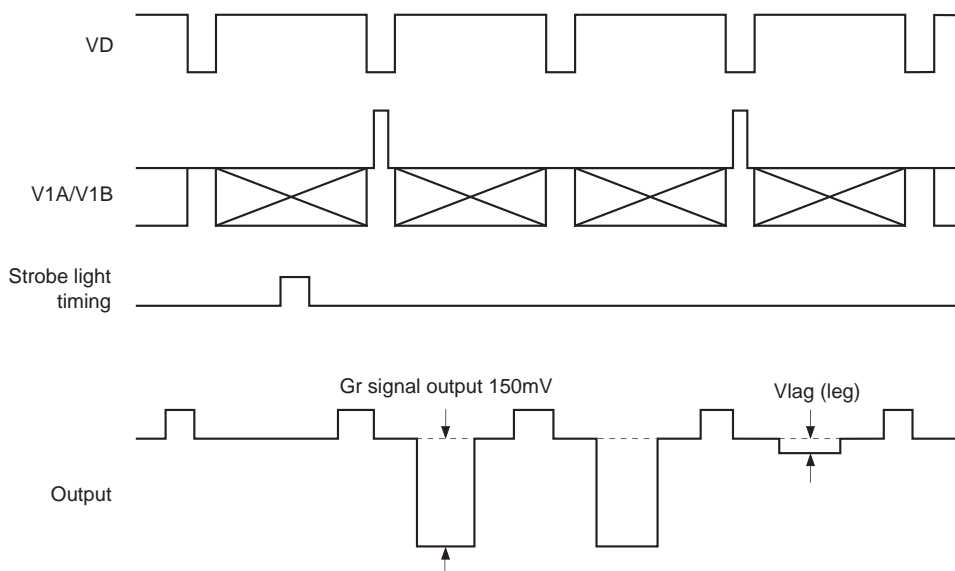
7. Line crawl

   Set to standard imaging condition II. Adjusting the luminous intensity so that the average value of the Gr signal output is 150mV, and then insert R, G and B filters and measure the difference between G signal lines (ΔGlr, ΔGlg, ΔGlb [mV]) as well as the average value of the G signal output (Gar, Gag, Gab). Substitute the values into the following formula.

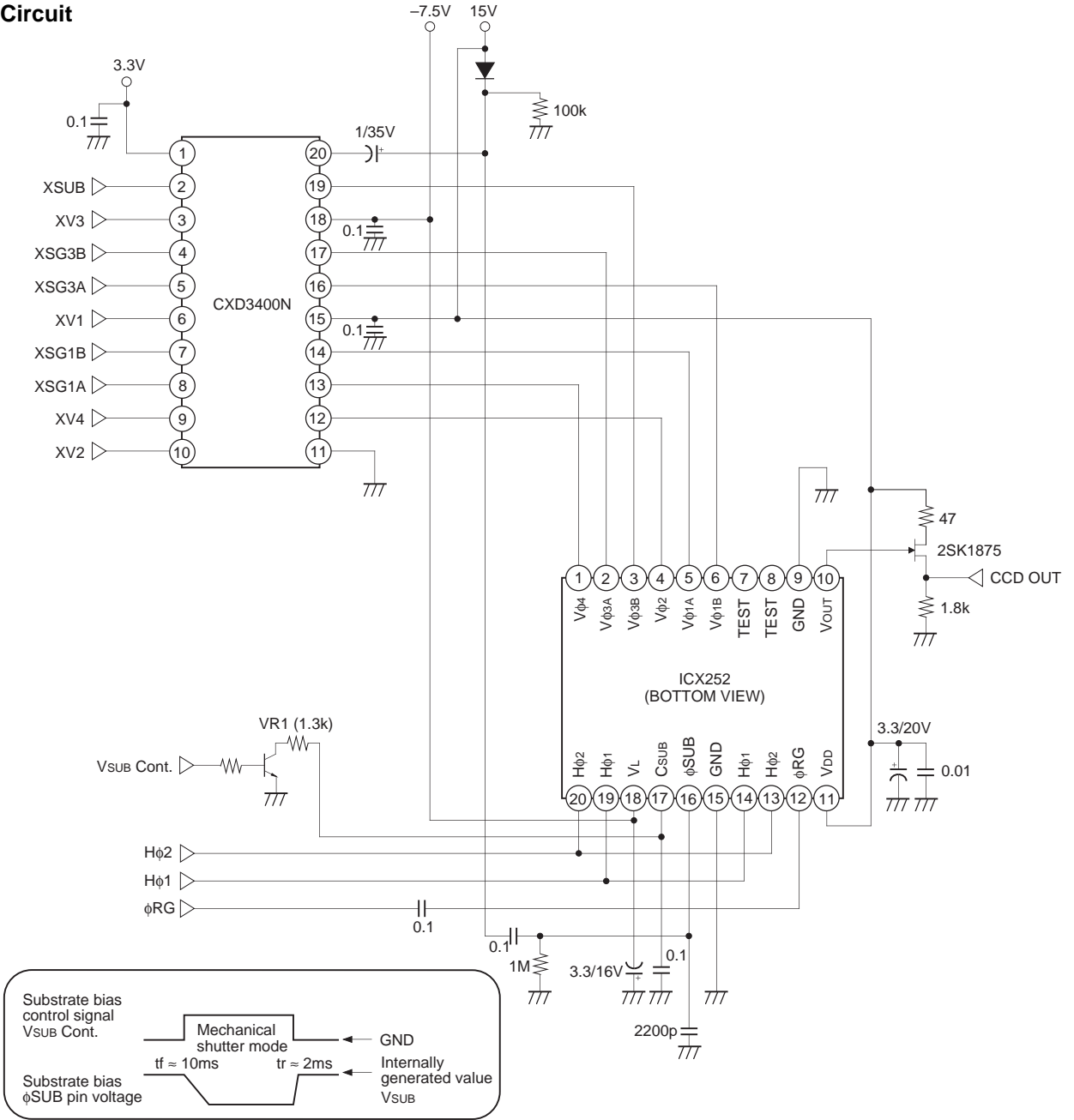 $$Lci = \frac{\Delta Gli}{Gai} \times 100 \text{ [\%] } (i = r, g, b)$$

8. Lag

   Adjust the Gr signal output value generated by strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal (Vlag). Substitute the value into the following formula.

   $$Lag = (Vlag/150) \times 100 \text{ [\%]}$$

Drive Circuit

Substrate bias control signal VSUB Cont.
Mechanical shutter mode
GND
tf ≈ 10ms   tr ≈ 2ms
Internally generated value VSUB
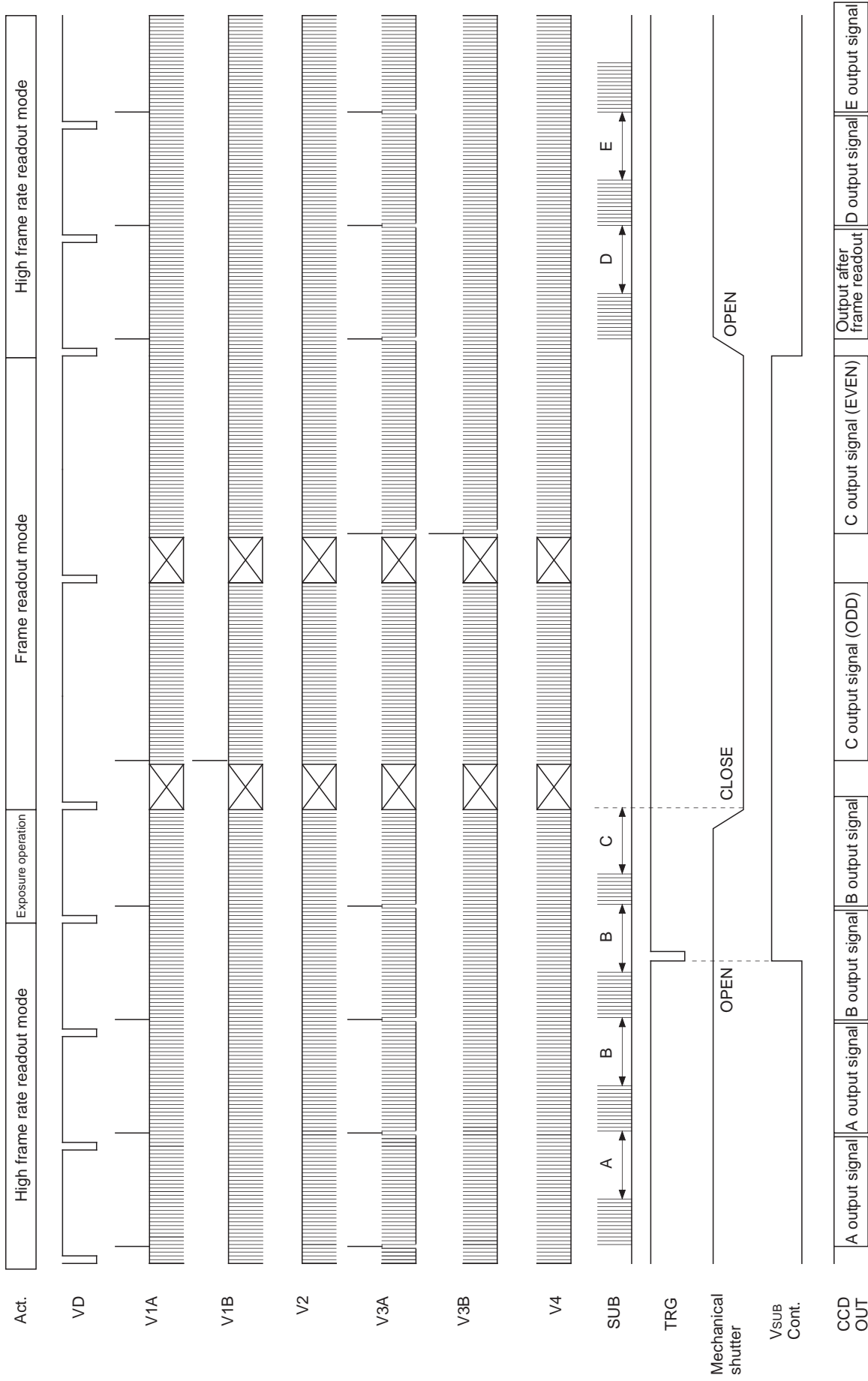Substrate bias φSUB pin voltage

Notes)
Substrate bias control
  1. The saturation signal level decreases when exposure is performed using the mechanical shutter, so control the substrate bias.
  2. A saturation signal level equivalent to that for continuous exposure can be assured by connecting a 1.3kΩ grounding resistor to the CCD C_{SUB} pin.
Drive timing precautions
  1. Blooming occurs in modes (high frame rate readout, etc.) that do not use the mechanical shutter, so do not ground the connected 1.3kΩ resistor.
  2. tf is slow, so the internally generated voltage V_{SUB} may not drop to a sufficiently low level if the substrate bias control signal is not set to high level 40ms before entering the exposure period and the 1.3kΩ resistor connected to the C_{SUB} pin is not grounded.
  3. The blooming signal generated during exposure in mechanical shutter mode is swept by providing one field or more of idle transfer through vertical register high-speed sweep transfer from the time the mechanical shutter closes until sensor readout is performed. However, note that the V_L potential and the φSUB pin DC voltage sag at this time.
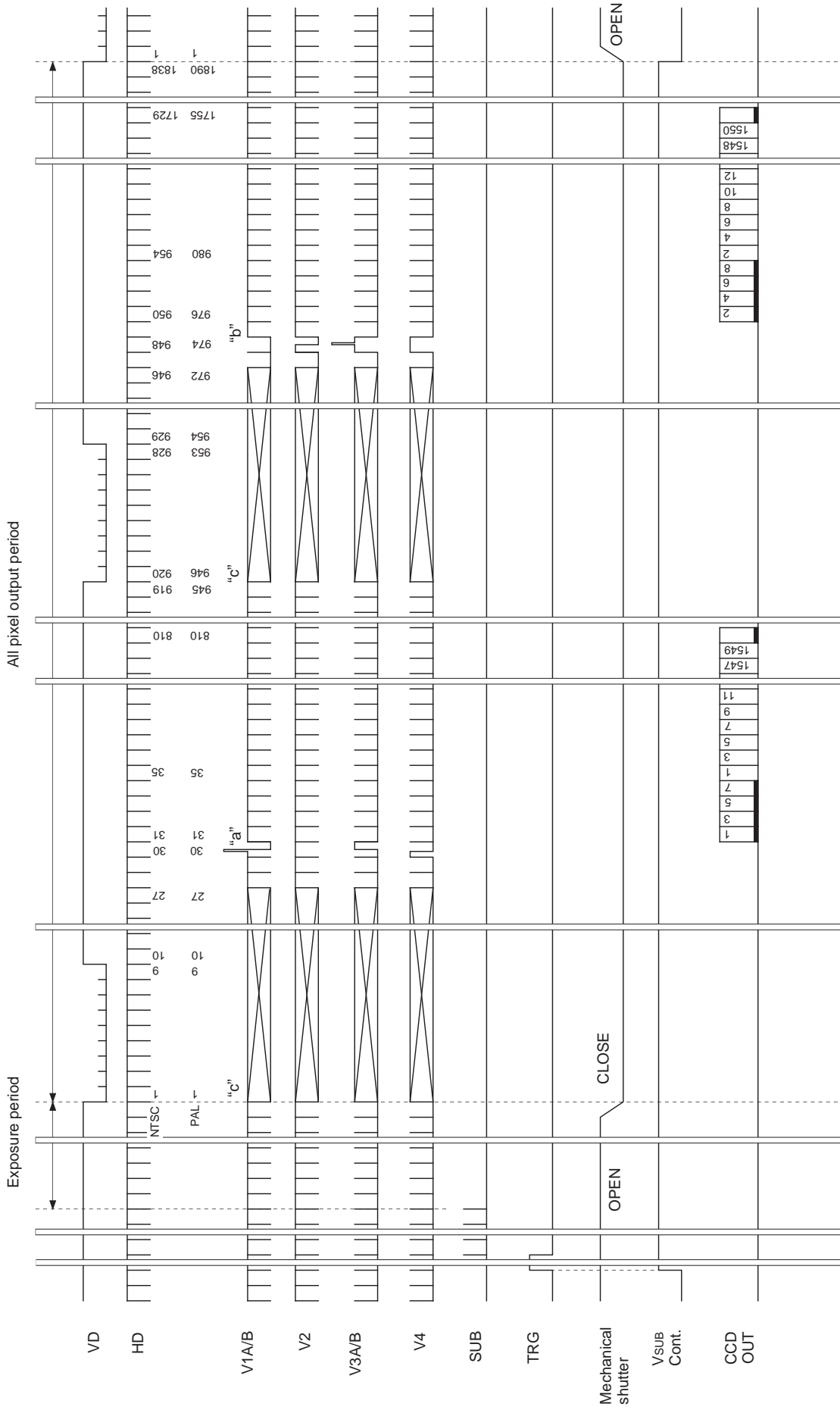
Drive Timing Chart (Vertical Sequence)   High Frame Rate Readout Mode → Frame Readout Mode/Electronic Shutter Normal Operation

Act.

| High frame rate readout mode | Frame readout mode | | High frame rate readout mode |
| | Exposure operation | Frame readout mode | |

VD

V1A

V1B

V2

V3A

V3B

V4

SUB   A   B   B   C   D   E

TRG

Mechanical shutter   OPEN   CLOSE   OPEN

Vsub Cont.

CCD OUT

| A output signal | A output signal | B output signal | B output signal | C output signal (ODD) | C output signal (EVEN) | Output after frame readout | D output signal | E output signal |

Note) The B output signal contains a blooming component and should therefore not be used.

Drive Timing Chart (Vertical Sync)   **NTSC/PAL Frame Readout Mode**
NTSC: 4.28 frame/s, PAL: 4.17 frame/s

Exposure period

All pixel output period

Signal rows: VD, HD, V1A/B, V2, V3A/B, V4, SUB, TRG, Mechanical shutter, VSUB Cont., CCD OUT
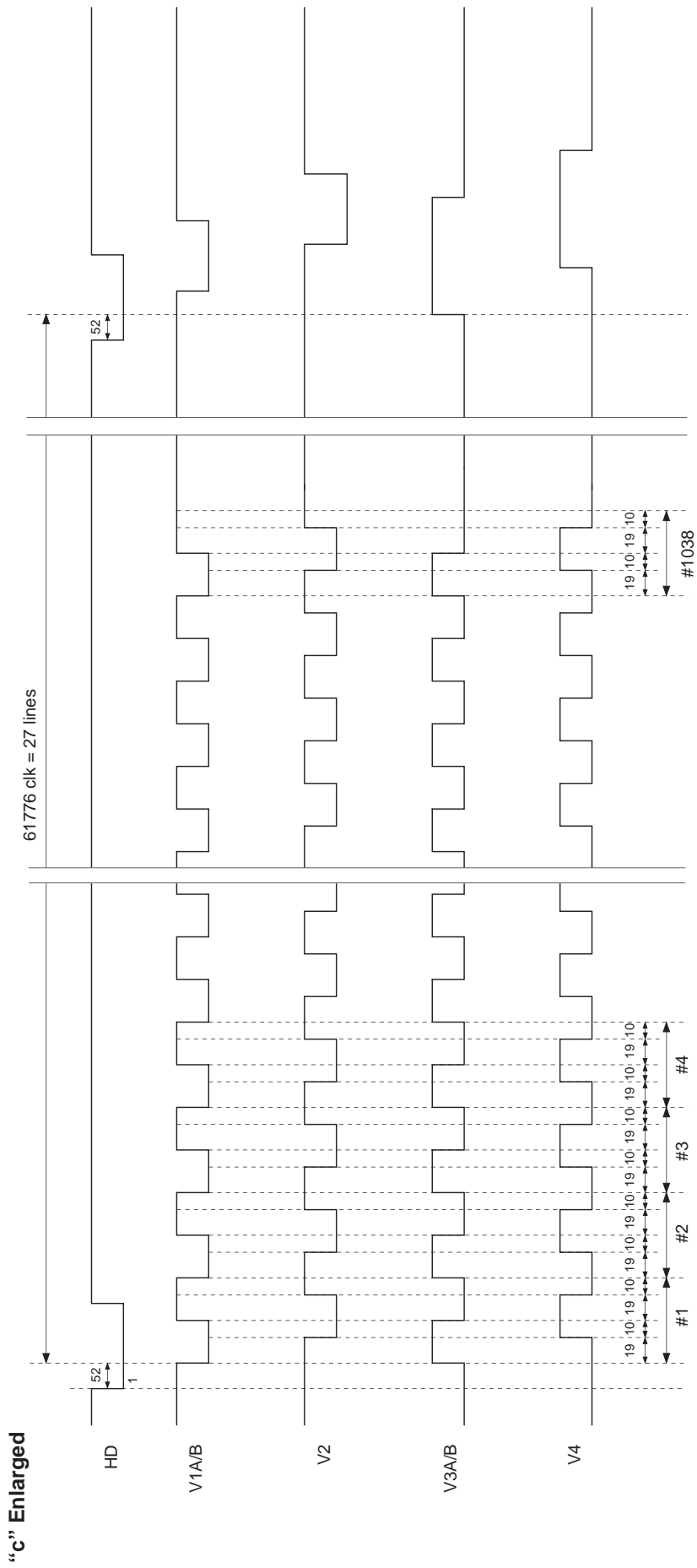
OPEN / CLOSE

Note) 2288fH, However, 919H and 1828H in NTSC mode are 1716 clk, and 944H, 945H, 1889H and 1890H in PAL mode are 1208 clk.

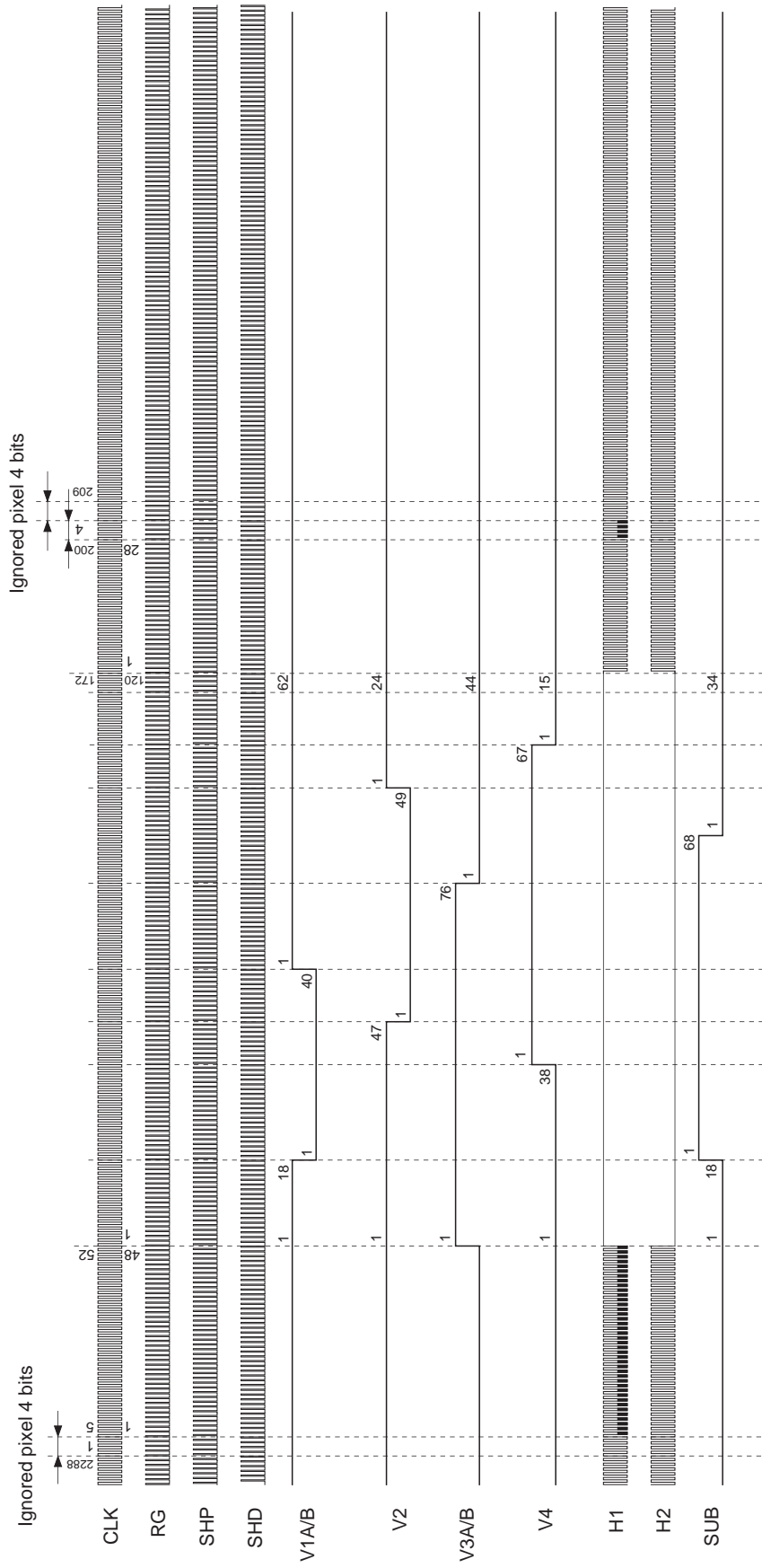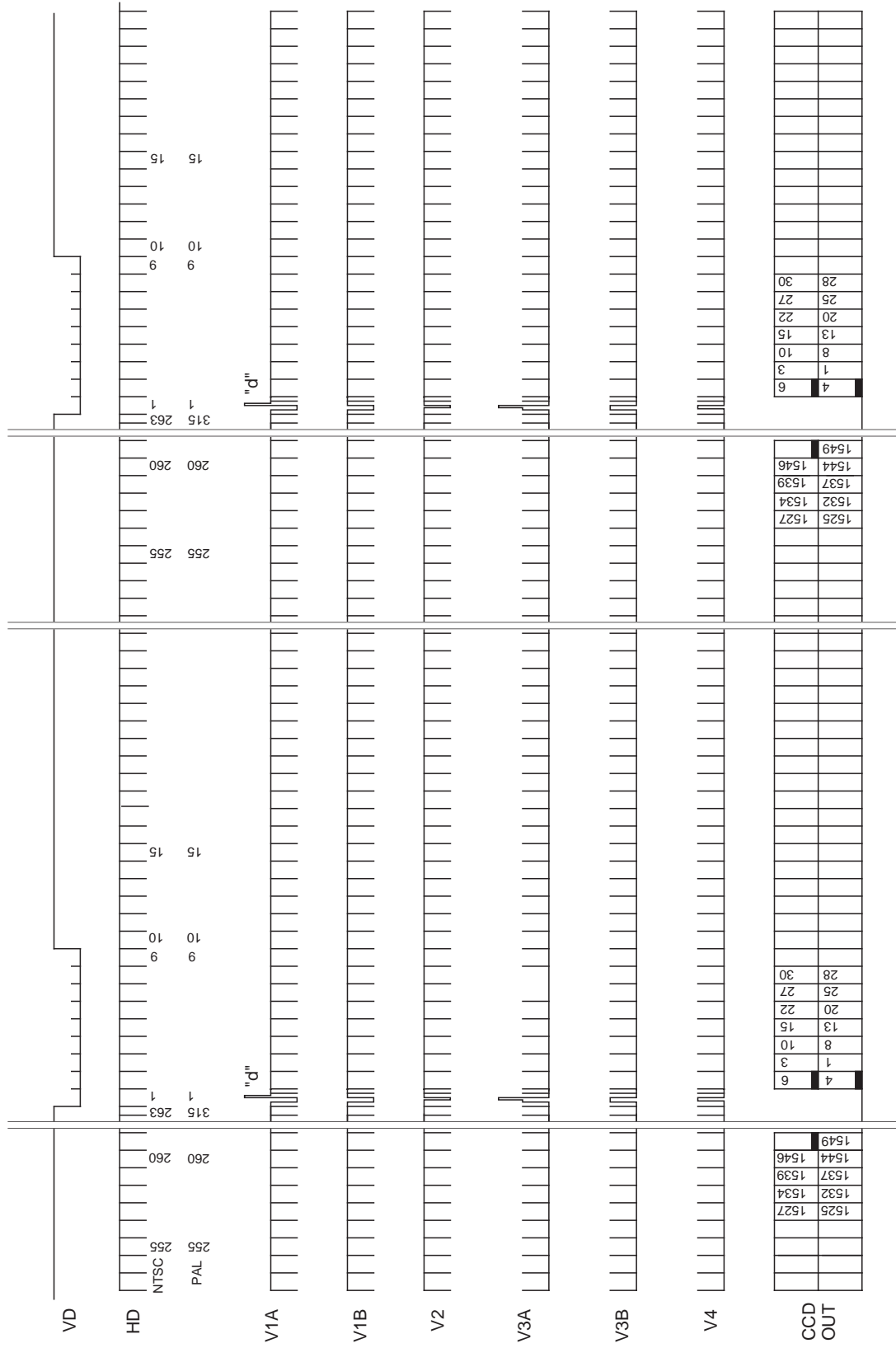**Drive Timing Chart (Readout)   NTSC/PAL Frame Readout Mode**

"a" Enlarged

NTSC: #30
PAL : #30

NTSC: #31
PAL : #31

NTSC: #948
PAL : #974

NTSC: #949
PAL : #975

H1
V1A/B
V2
V3A/B
V4

"b" Enlarged
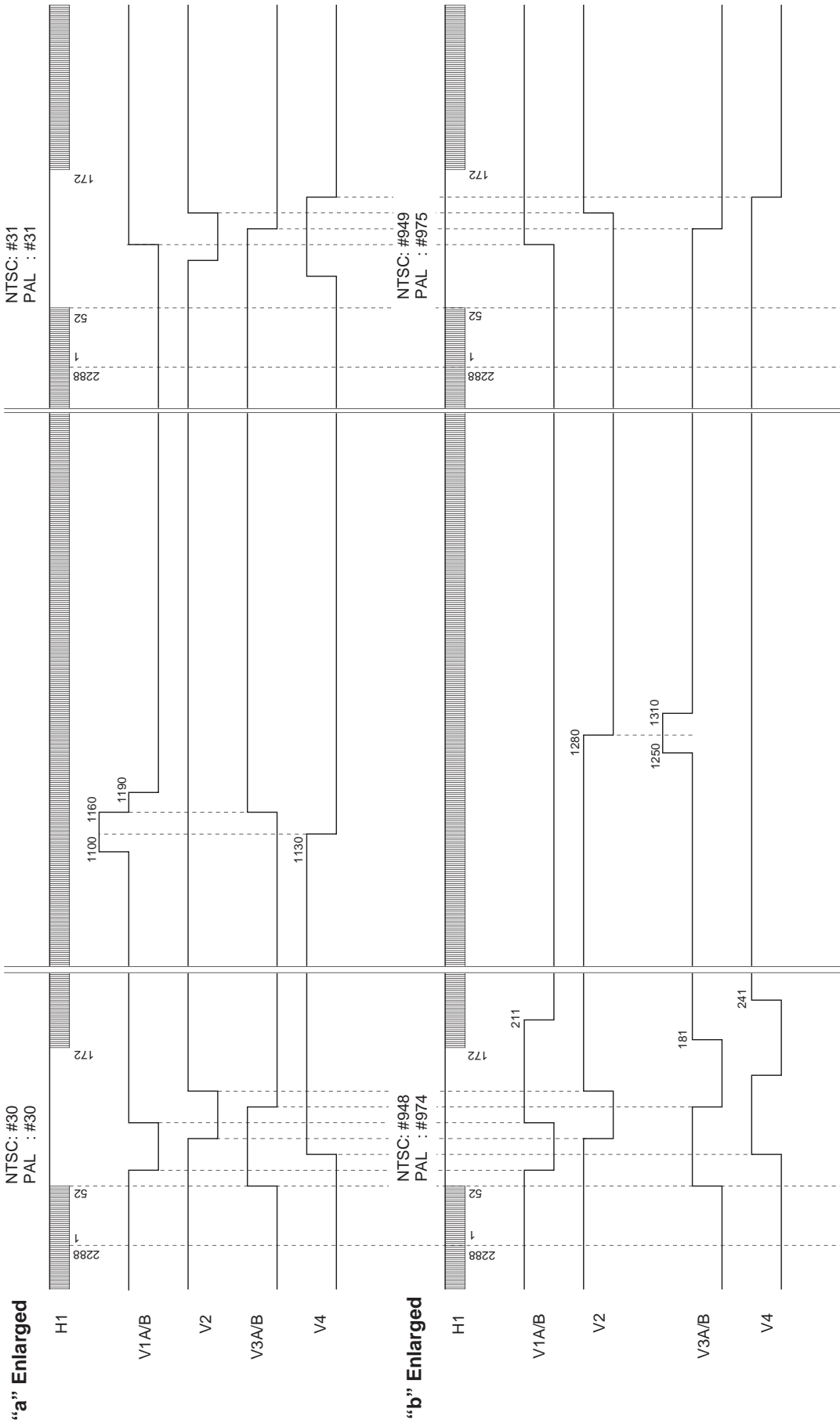
Drive Timing Chart (High-speed Sweep Operation)   NTSC/PAL Frame Readout Mode

"c" Enlarged

61776 clk = 27 lines

#1038

HD

V1A/B

V2

V3A/B

V4
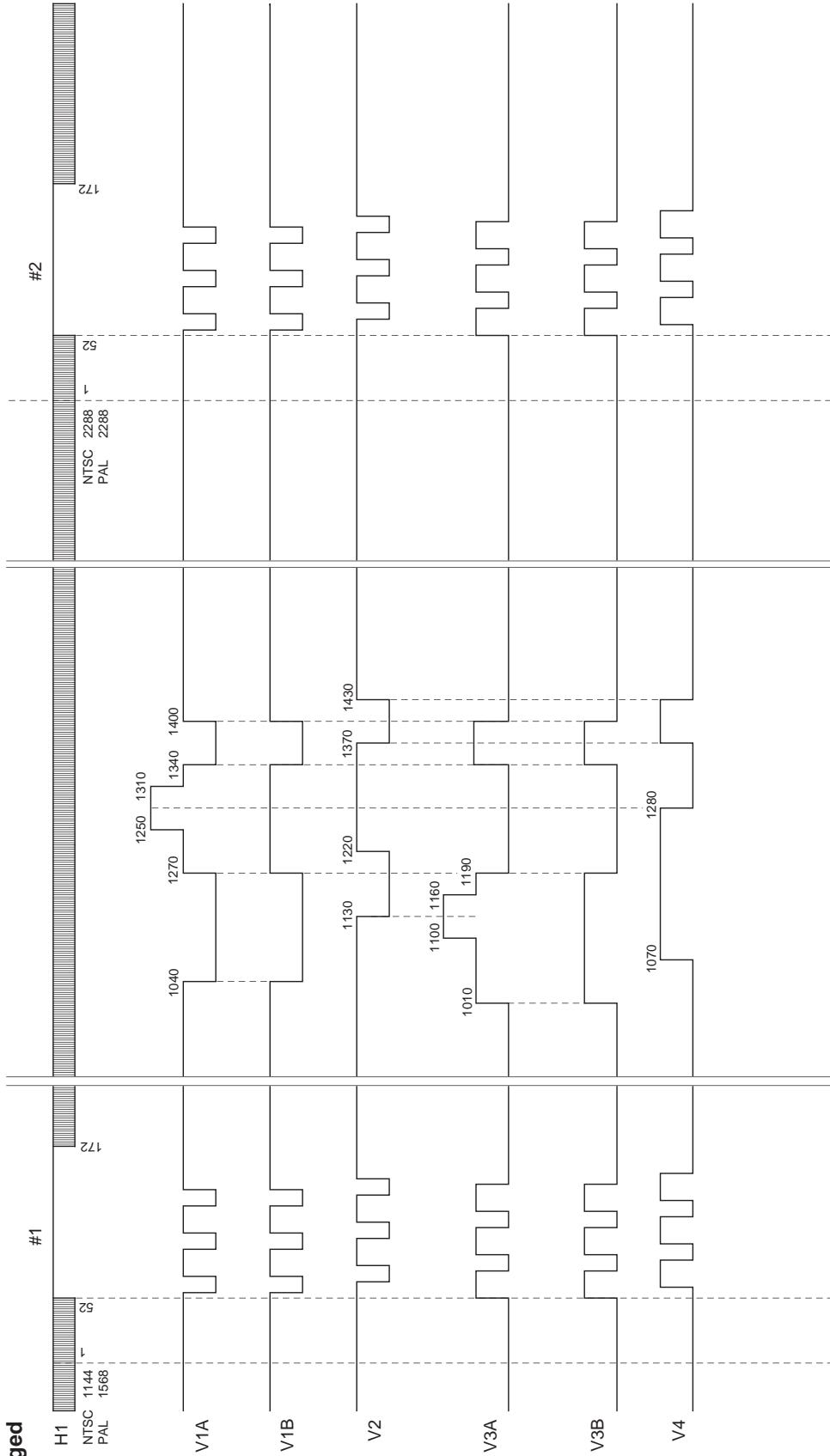
Drive Timing Chart (Horizontal Sync)   NTSC/PAL Frame Readout Mode

Drive Timing Chart (Vertical Sync)   NTSC/PAL High Frame Rate Readout Mode
NTSC: 30 frame/s, PAL: 25 frame/s

VD

HD

NTSC   PAL

255   255

260   260

263   315
1   1

6   9
10   10

15   15

V1A   "d"

V1B

V2

V3A

V3B

V4

CCD OUT

NTSC	PAL
1525	1527
1532	1534
1537	1539
1544	1546
1549	

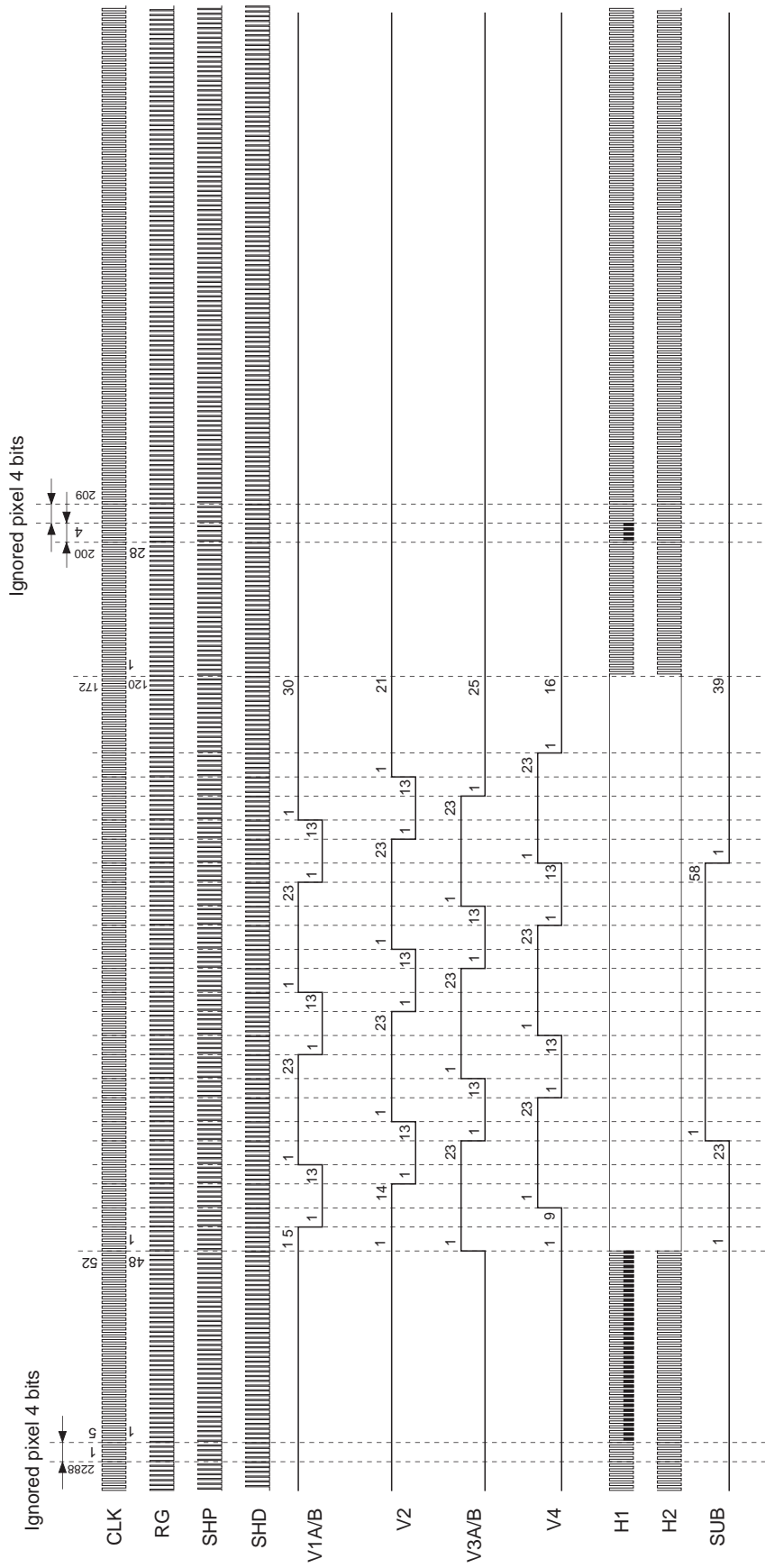| NTSC	PAL
4	6
1	3
8	10
13	15
20	22
25	27
28	30

Note) 2288fH, However, 263H in NTSC mode is 1144 clk, and 315H in PAL mode is 1568 clk.

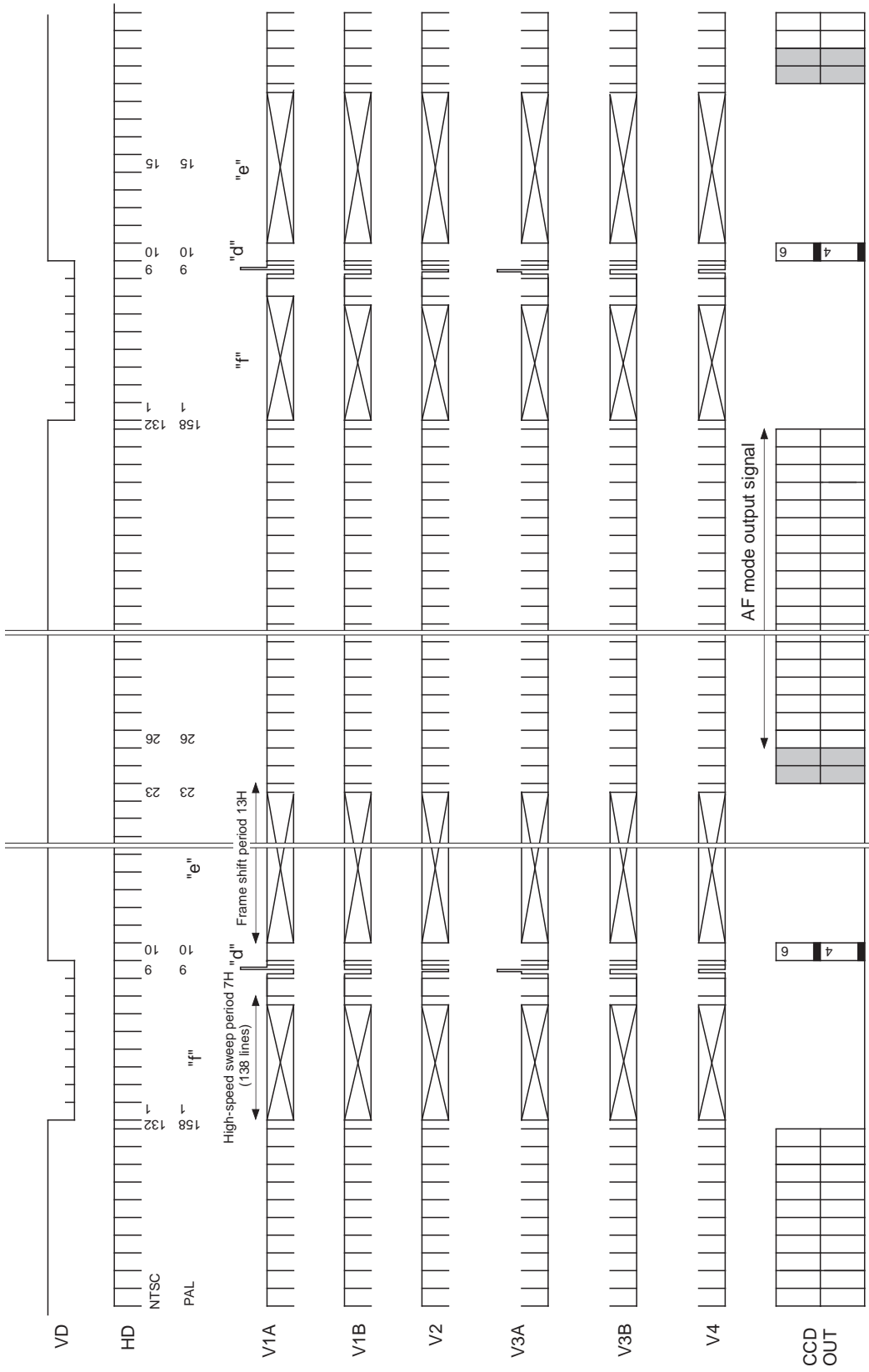**Drive Timing Chart (Readout)   NTSC/PAL High Frame Rate Readout Mode**

"d" Enlarged

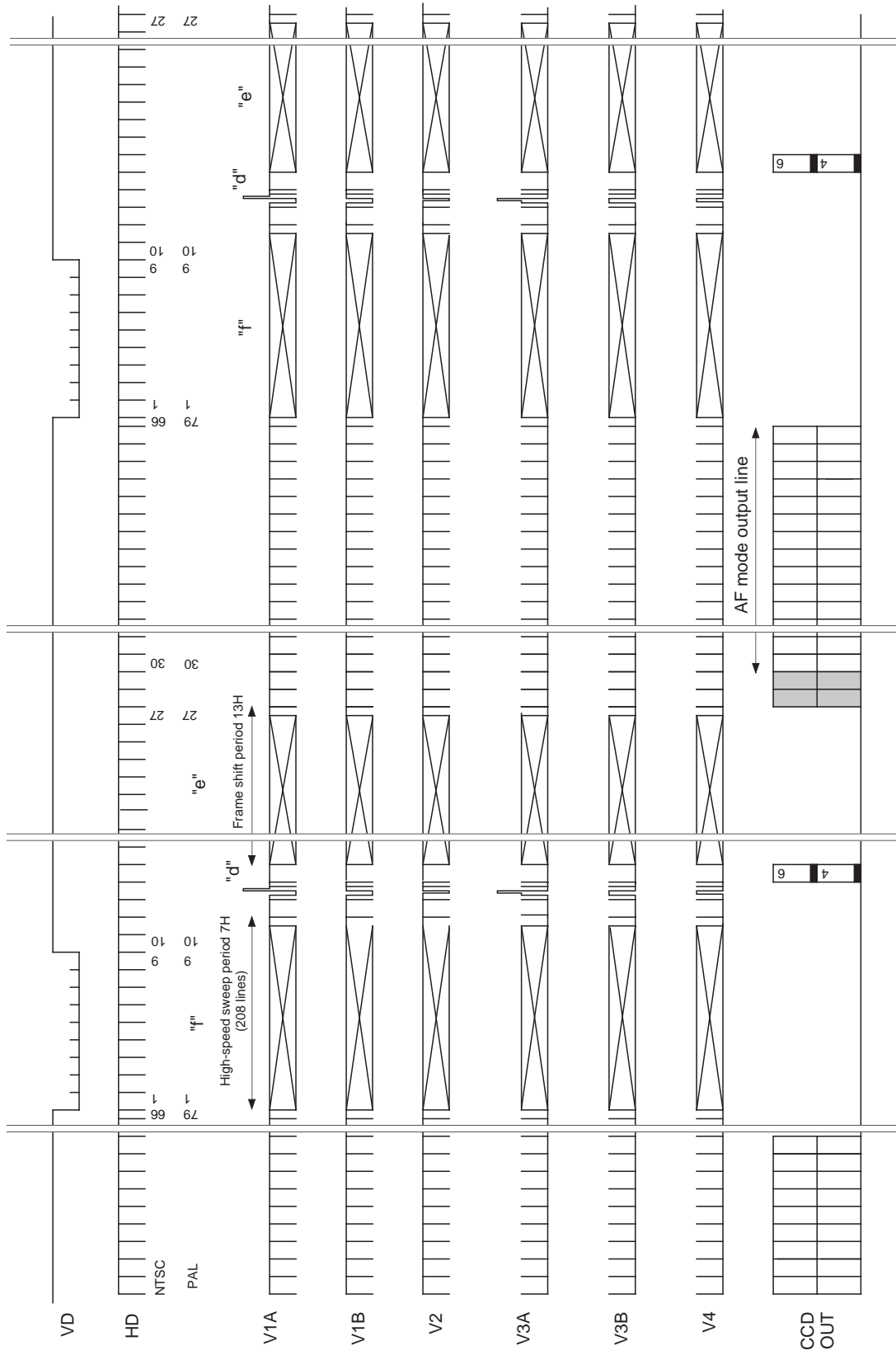**Drive Timing Chart (Horizontal Sync)   NTSC/PAL High Frame Rate Readout Mode, AF1 Mode, AF2 Mode**

**Drive Timing Chart (Vertical Sync)   NTSC/PAL AF1 Mode
NTSC: 60 frame/s, PAL: 50 frame/s**

High-speed sweep period 7H (138 lines)
Frame shift period 13H

AF mode output signal

Note) 2288fH, However, 182H in NTSC mode is 572 clk, and 158H in PAL mode is 784 clk.

VD
HD NTSC PAL
V1A V1B V2 V3A V3B V4
CCD OUT

Drive Timing Chart (Vertical Sync) 　**NTSC/PAL AF2 Mode**
NTSC: 120 frame/s, PAL: 100 frame/s

VD

HD

NTSC
PAL

V1A

V1B

V2

V3A

V3B

V4

CCD
OUT

High-speed sweep period 7H (208 lines)

Frame shift period 13H

AF mode output line

"d"

"e"

"f"

27 27

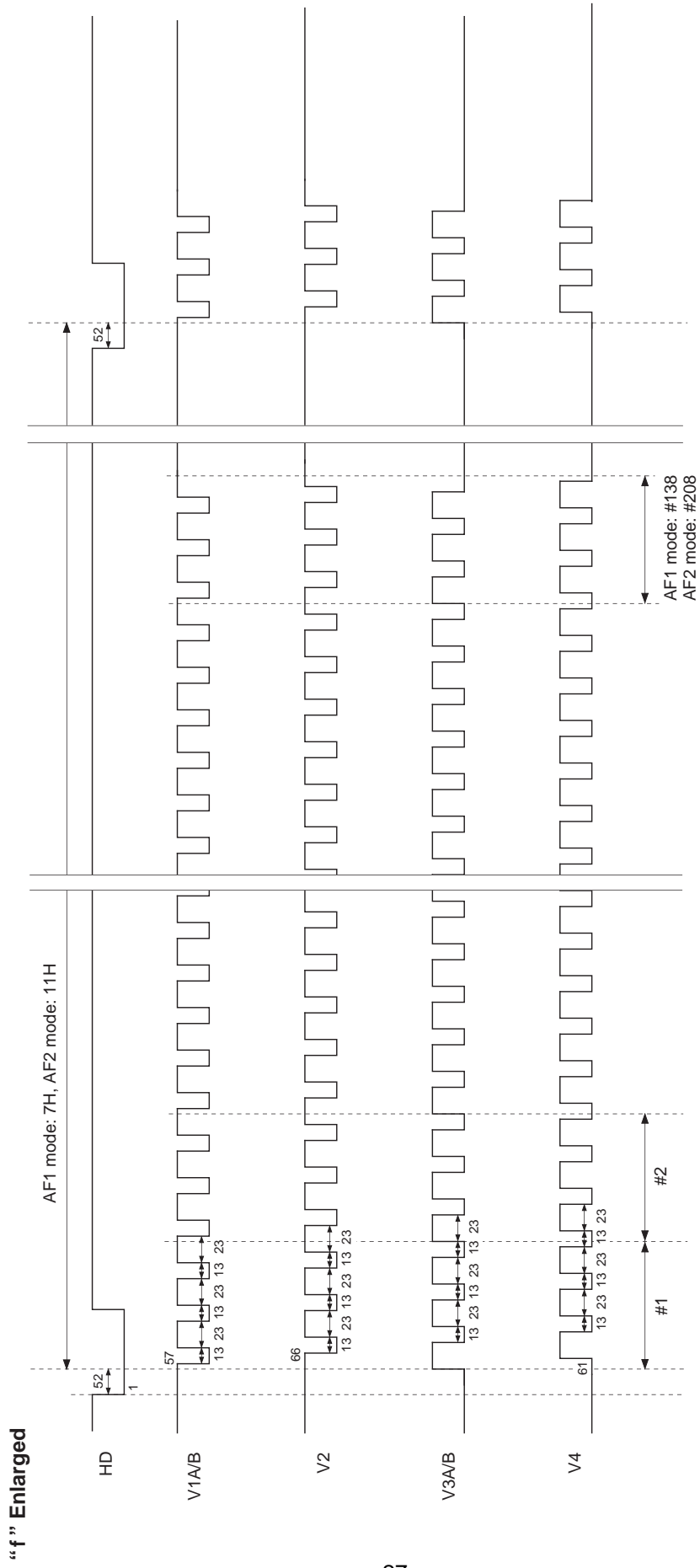9 10
9 10

79 1
66 1

27 30
27 30

6
4

Note) 2288fH, However, 66H in NTSC mode is 1430 clk, and 79H in PAL mode is 1356 clk.

Drive Timing Chart (High-speed Frame Shift Operation)   NTSC/PAL AF1 Mode, AF2 Mode

"e" Enlarged

HD

V1A/B

V2

V3A/B

V4

i = 0 to 255

13H

52

52

57

66

61

1

13 23 13 23 13 23

13 23 13 23 13 23

13 23 13 23 13 23

13 23 13 23 13 23

#1

#2

Drive Timing Chart (High-speed Sweep Operation)   NTSC/PAL AF1 Mode, AF2 Mode

"f" Enlarged
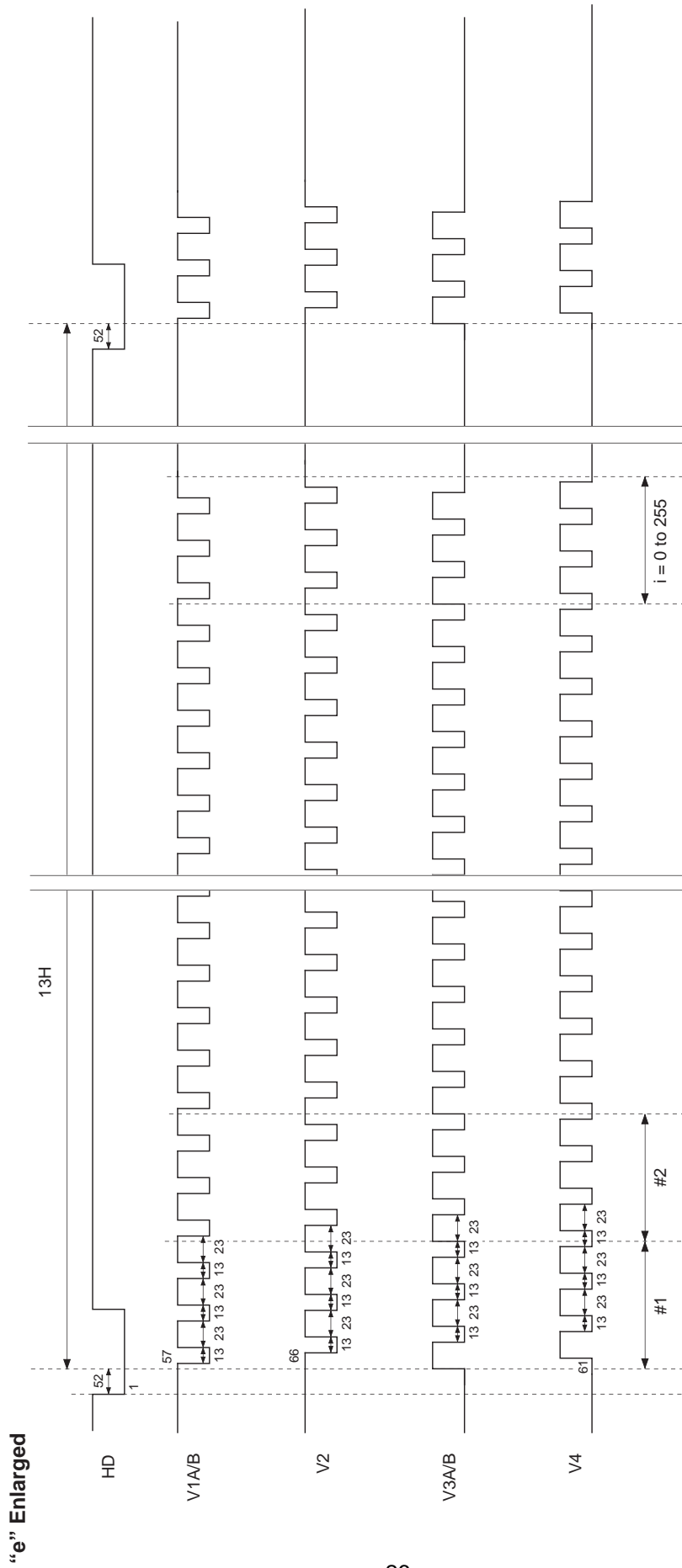
Notes on Handling

1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

a) Either handle bare handed or use non-chargeable gloves, clothes or material.

Also use conductive shoes.

b) When handling directly use an earth band.

c) Install a conductive mat on the floor or working table to prevent the generation of static electricity.

d) Ionized air is recommended for discharge when handling CCD image sensors.

e) For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

2) Soldering

a) Make sure the package temperature does not exceed 80°C.

b) Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a ground 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.

c) To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero-cross On/Off type and connect it to ground.

3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operations as required, and use them.

a) Perform all assembly operations in a clean room (class 1000 or less).

b) Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)

c) Clean with a cotton bud and ethyl alcohol if grease stained. Be careful not to scratch the glass.

d) Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.

e) When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.

4) Installing (attaching)

a) Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)

Cover glass

Plastic package

50N

Compressive strength

50N

Torsional strength

1.2Nm
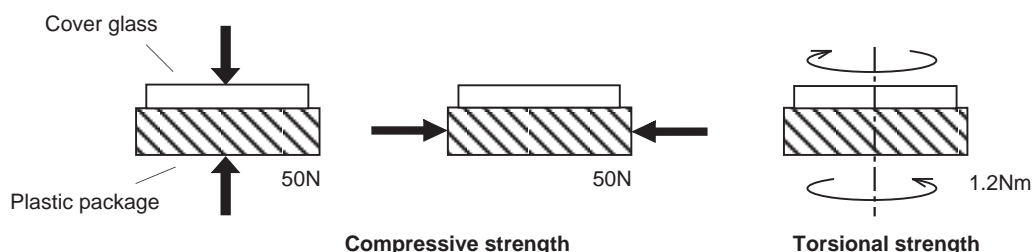
b) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.

d) The notch of the package is used for directional index, and that can not be used for reference of fixing.
In addition, the cover glass and seal resin may overlap with the notch of the package.

e) If the leads are bent repeatedly and metal, etc., clash or rub against the package, the dust may be generated by the fragments of resin.

f) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyano-acrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

5) Others

a) Do not expose to strong light (sun rays) for long periods, as color filters will be discolored. When high luminous objects are imaged with the exposure level controlled by the electronic iris, the luminance of the image-plane may become excessive and discoloring of the color filter will possibly be accelerated. In such a case, it is advisable that taking-lens with the automatic-iris and closing of the shutter during the power-off mode should be properly arranged. For continuous using under cruel condition exceeding the normal using condition, consult our company.

b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.

c) Brown stains may be seen on the bottom or side of the package. But this does not affect the CCD characteristics.

Package Outline   Unit: mm

20pin SOP
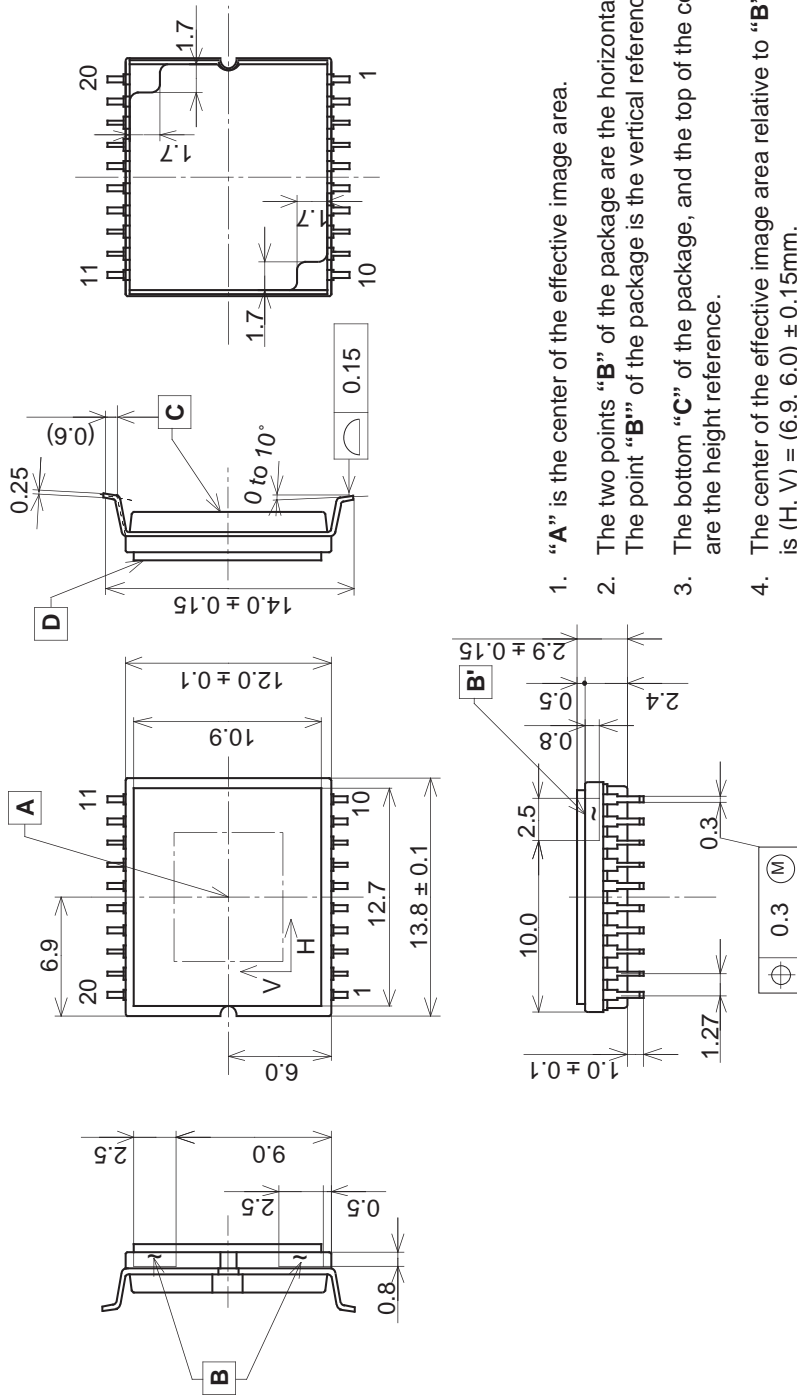
1. "**A**" is the center of the effective image area.

2. The two points "**B**" of the package are the horizontal reference.
   The point "**B'**" of the package is the vertical reference.

3. The bottom "**C**" of the package, and the top of the cover glass "**D**"
   are the height reference.

4. The center of the effective image area relative to "**B**" and "**B'**"
   is (H, V) = (6.9, 6.0) ± 0.15mm.

5. The rotation angle of the effective image area relative to H and V is ± 1°.

6. The height from the bottom "**C**" to the effective image area is 1.41 ± 0.10mm.
   The height from the top of the cover glass "**D**" to the effective image area is 1.49 ± 0.15mm.

7. The tilt of the effective image area relative to the bottom "**C**" is less than 50µm.
   The tilt of the effective image area relative to the top "**D**" of the cover glass is less than 50µm.

8. The thickness of the cover glass is 0.5mm, and the refractive index is 1.5.

9. The notches on the bottom of the package are used only for directional index, they must
   not be used for reference of fixing.

PACKAGE STRUCTURE

PACKAGE MATERIAL	Plastic
LEAD TREATMENT	GOLD PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	0.95g
DRAWING NUMBER	AS-B7-01(E)